

DE LA RECHERCHE À L'INDUSTRIE



A DFA ON AES BASED ON THE ENTROPY OF ERROR DISTRIBUTIONS

FDTC2012 |

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Introduction

- In order to design secure cryptosystems, one has to assess the risks of potential attacks.
- We want to discuss about the practical implementation of attacks, more precisely about the fault models.
- We want a DFA:
 - **General**: can be used with all injection means.
 - **Adaptive**: the efficiency increases when the fault model is more restrictive.
 - **Simple** to implement.
 - **Without prior knowledge** of the fault model...
 - Or **with prior knowledge** and higher efficiency.
 - Helped by some countermeasures!

Section 1 – Context

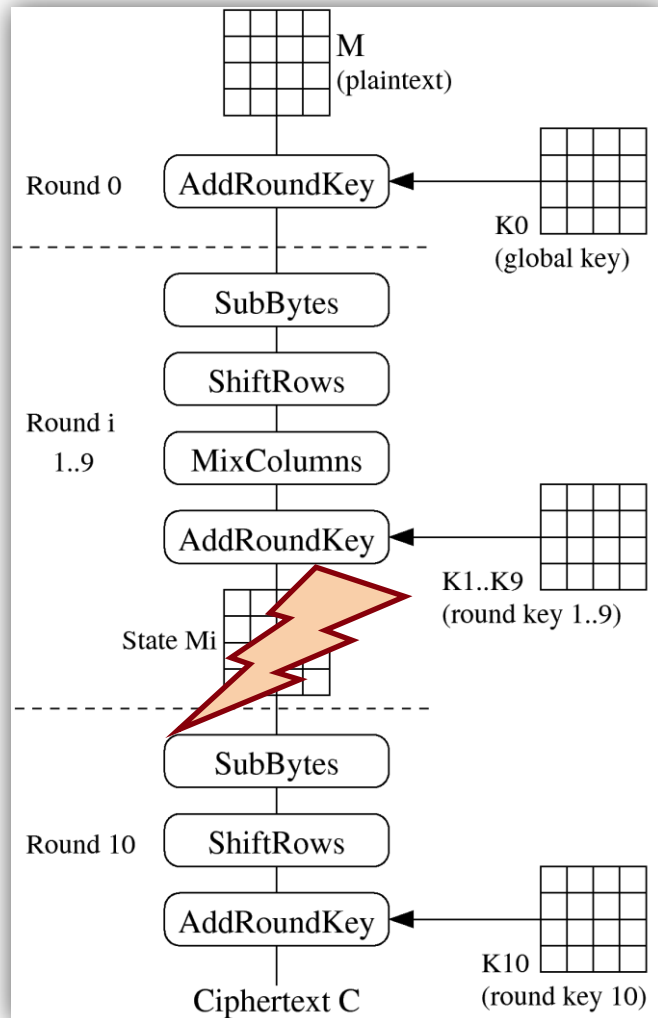
Section 2 – Entropy-based methodology

Section 3 – Improving entropy-based tools

SECTION 1

CONTEXT

AES-128

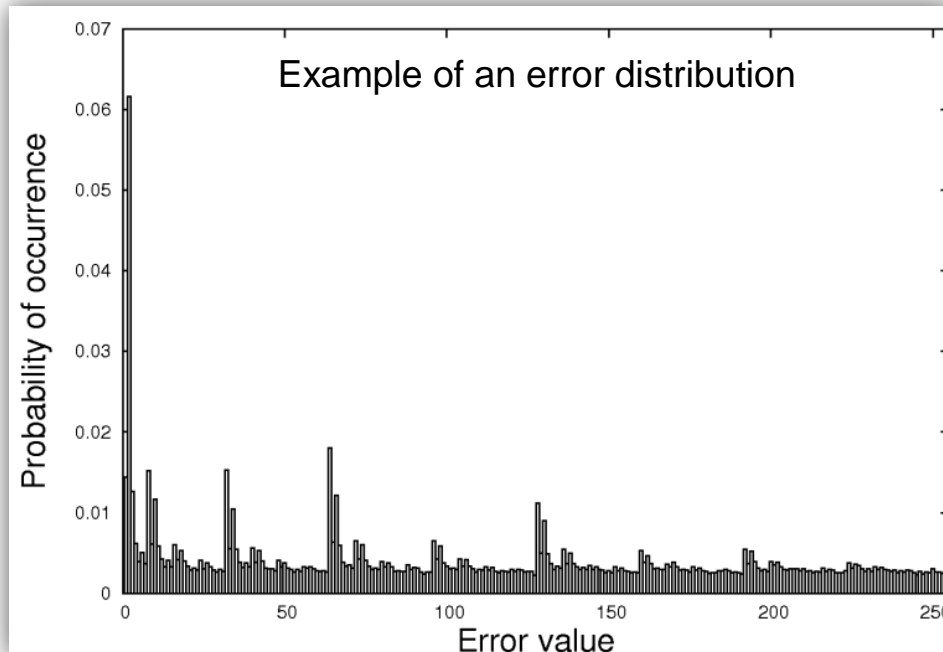


Differential Fault Analysis

- Attacker corrupts one of the intermediate states of the AES.
- Attacker performs a differential cryptanalysis between the correct cipher (C) and the erroneous one (D) to infer information about the secret key.

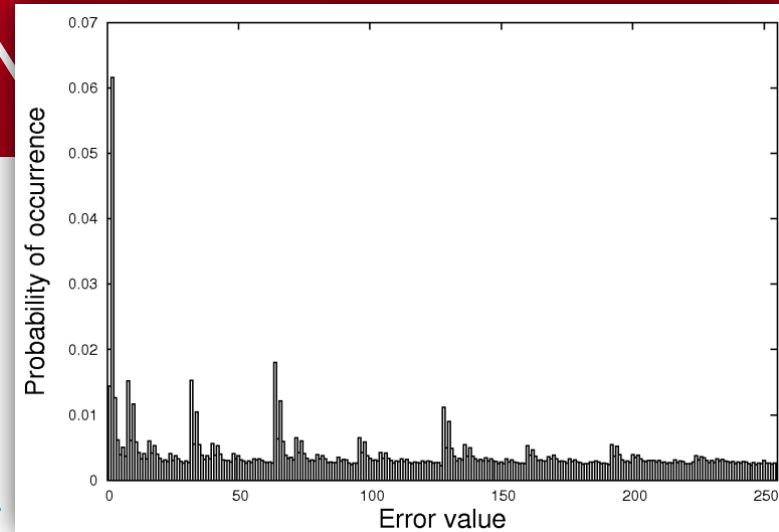
CONTEXT: FAULT MODELS

- The **fault model** is the set of restrictions put on the injected faults.
- Common examples are:
 - Single bit faults ($2^{3 \cdot 16} = 2^{48}$ authorized faults on the State)
 - Single byte faults ($(4 \cdot 2^8)^4 = 2^{40}$ authorized faults on the State)
- Key extraction analyses are:
 - Either restrictive (*Giraud's: 2^{48} , Piret's: 2^{40} ...*)
 - Either inefficient: a high number of fault injections is required (*Moradi's: $2^{127.9}$...*)
- We represent a fault model with an **error distribution**. (2^{128})

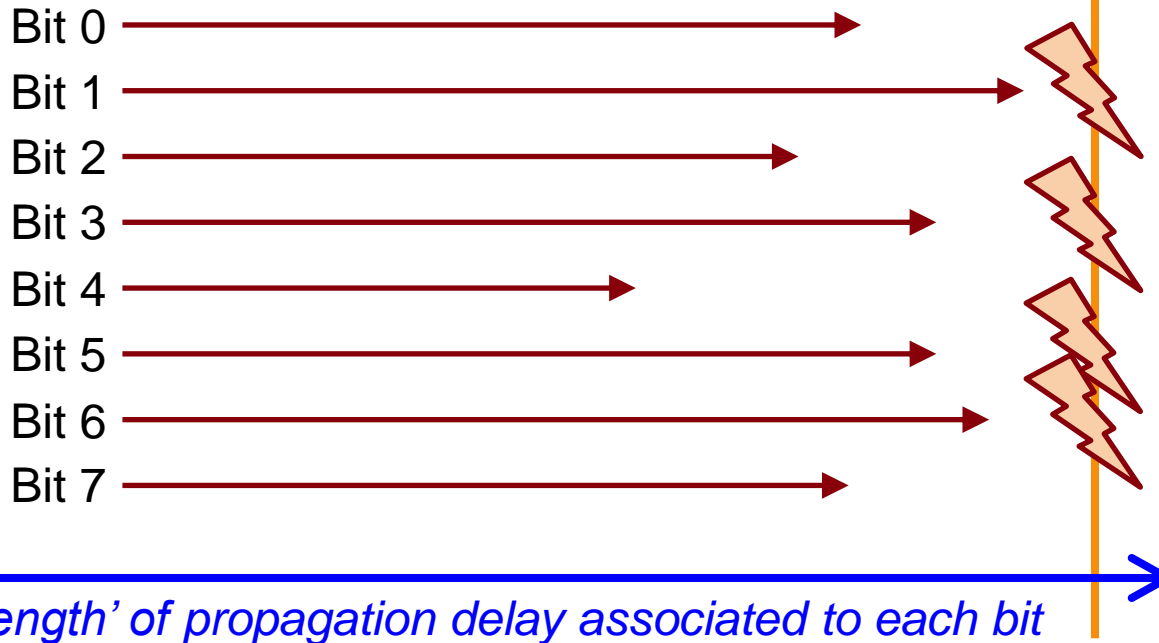


CLOCK GLITCHES

- Clock glitches create memorization faults in registers through setup time violations.
- Faults are probabilistic.
- Distributions can be used for all injection means.



Bits of AES's State

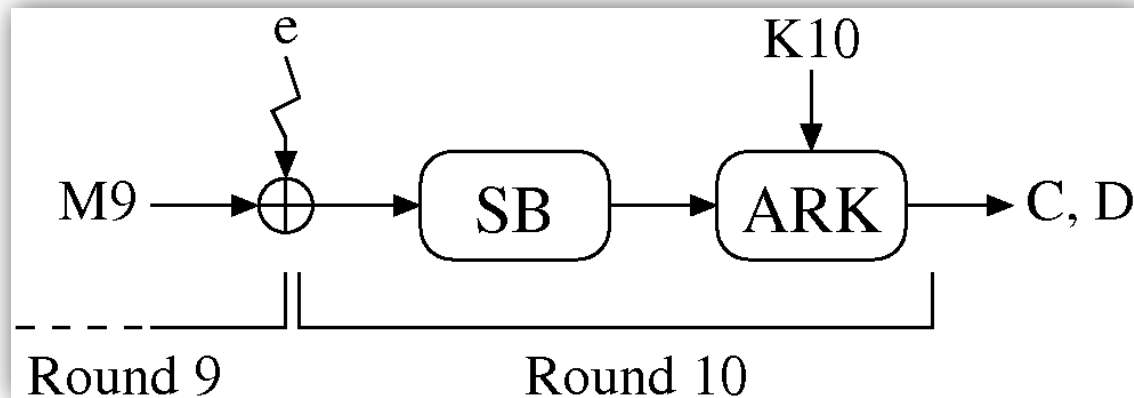


Clock period

SECTION 2
ENTROPY-BASED METHODOLOGY

ENTROPY: OUR ANALYSIS

- In order to work, our analysis needs the following hypotheses:
 - The faults are **bit-flip**.
 - The faults are **not uniformly distributed**.*
 - The faults are injected on M9.
- *From now on we shall concentrate on individual bytes...*
- The correct key byte is noted K_{10} .
- For each realization i :
 - First a valid encryption is executed (C_i).
 - Then a fault is injected on M9 and the faulty cipher value is memorized (D_i).



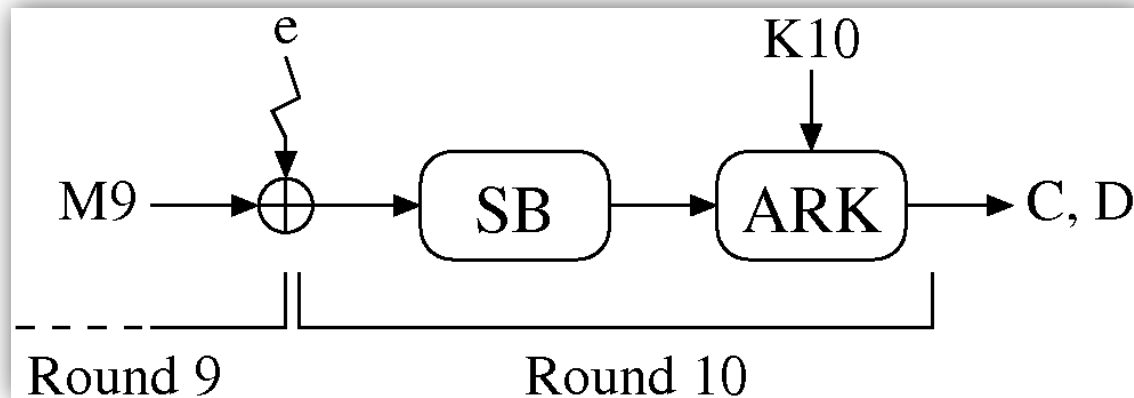
* A work based on a similar principle can be found in *DFA on DES middle rounds* by M. Rivain (CHES 2009)

ENTROPY: RECONSTRUCTING THE FAULT MODEL

- From C_i and D_i (correct and faulty ciphers)
- Given a key guess s ,
- The fault guess $e_{i,s}$ is computed with:

$$M9_{i,s} = SB^{-1}(C_i \oplus s)$$

$$e_{i,s} = M9_{i,s} \oplus SB^{-1}(D_i \oplus s)$$



RK-table

- We can now construct the Realization/Key hypothesis (RK) table, filled with $(e_{i,s})$.

Realization \ Key	0	1	...	255
0	$e_{0,0}$	$e_{0,1}$...	$e_{0,255}$
1	$e_{1,0}$	$e_{1,1}$...	$e_{1,255}$
...
i_{max}	$e_{i_{max},0}$	$e_{i_{max},1}$...	$e_{i_{max},255}$

- This table has two interesting properties:
 - Only one column (for $s = K10$) corresponds to faults actually injected.
 - For every wrong key guess, the corresponding column is quasi-random.

Finding the correct column

- The uniformity of a distribution is simply determined with Shannon entropy:

$$H(p_s) = - \sum_{e=0}^{255} p_s(e) \log_2 p_s(e)$$

- Decision criterion:

$$\text{■ } H(p_s) \xrightarrow{i_{max} \rightarrow \infty} 8 \text{ if } s \neq K10$$

$$\text{■ } H(p_{K10}) \xrightarrow{i_{max} \rightarrow \infty} H_{inj} < 8$$

- Valid only for sets of faults of infinite size

ENTROPY: DECISION CRITERION

Finding the correct column with a finite number of realizations

- Comparison with pseudo-random sets.
- i_{max} : number of realizations, $\mu_{i_{max}}^{rand}$: the mean, $\sigma_{i_{max}}^{rand}$: the standard deviation.
- $H(p_s)$ the measured entropy for the key guess s .
- We can express the confidence cf that an entropy of value H is not random by:

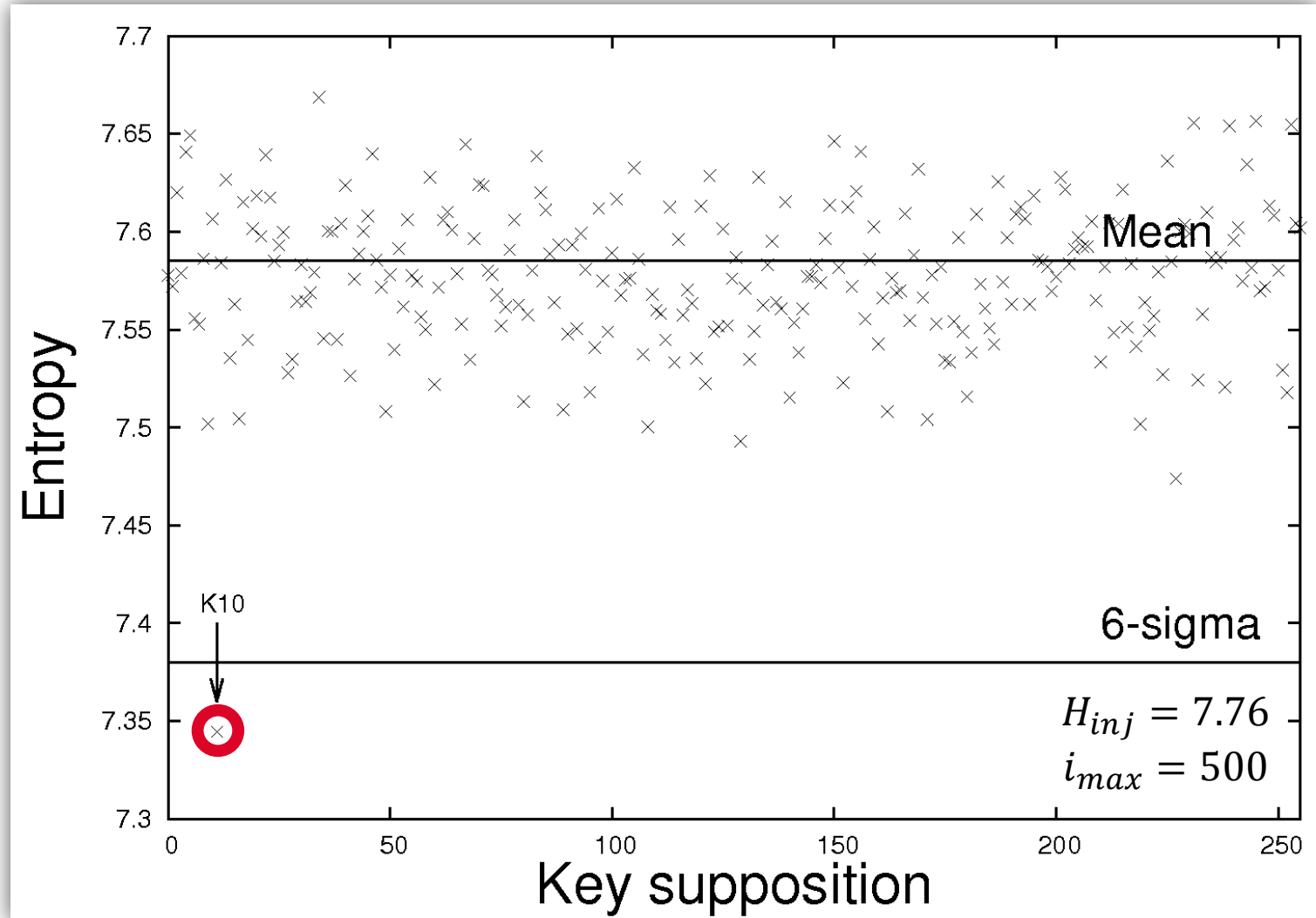
$$cf_{i_{max}}(H) = \frac{\mu_{i_{max}}^{rand} - H}{\sigma_{i_{max}}^{rand}}$$

- Decision criterion:

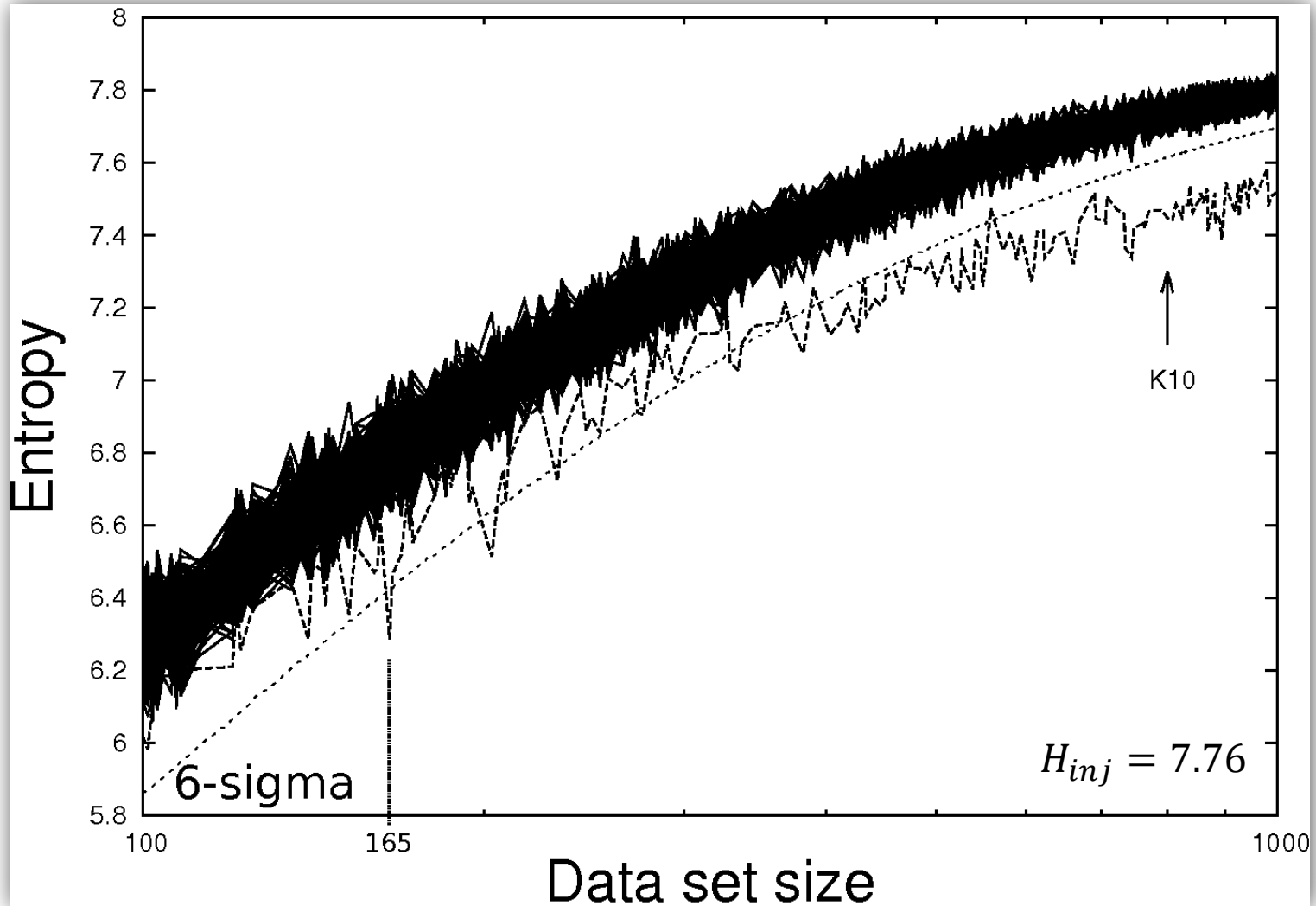
$$K10 = s \Leftrightarrow cf_{i_{max}}(H(p_s)) > X$$

- We chose with empirical calibration $X = 6$

ENTROPY: DECISION CRITERION EXAMPLE



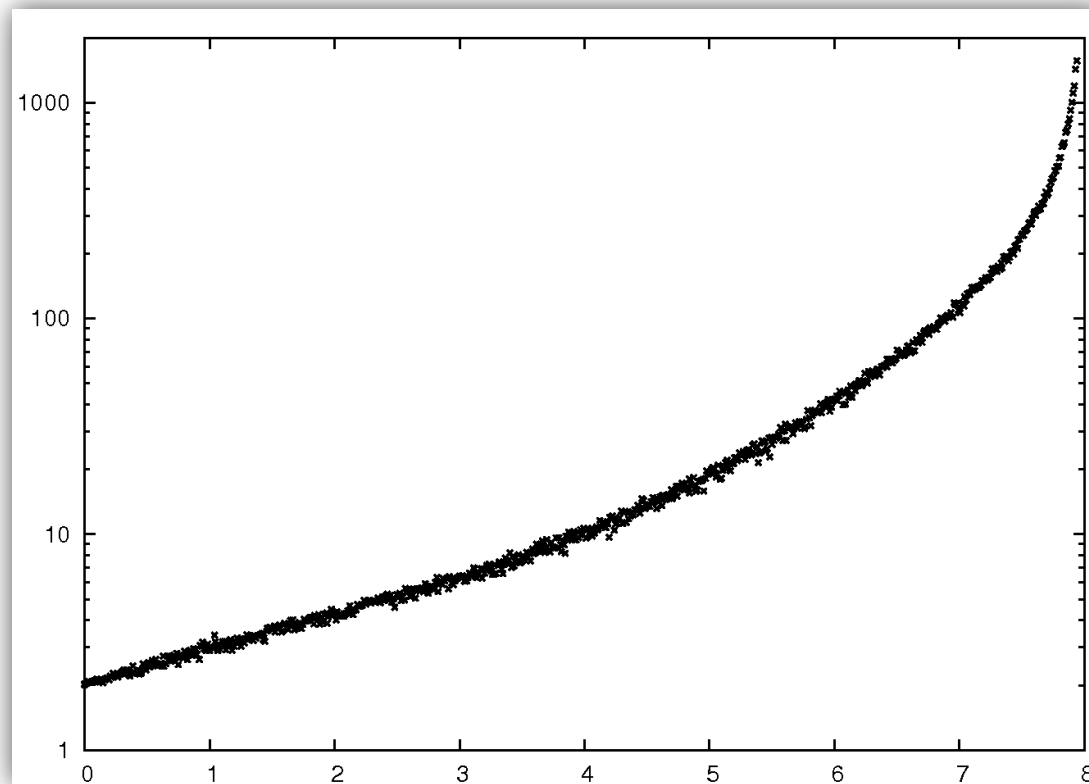
HOW ENTROPIES EVOLVE



ENTROPY: EFFICIENCY

- Using simulation, the entropy of the injection means may be linked with the attack efficiency.
- Attack efficiency is the average minimum number of faults needed to meet the decision criterion.

Average number of faults needed to find the key



Entropy of the injection means

ENTROPY: SUMMARY

- Our DFA is:
 - **General**: can be used with all injection means.
 - **Adaptive**: the efficiency increases when the fault model is tighter.
 - **Simple** to implement.
 - **Without prior knowledge** of the fault model...
 - ~~Or **with prior knowledge** and higher efficiency.~~
 - ~~Helped by some countermeasures!~~

- It is not particularly **efficient**: can we improve it?

	Average best attack
Shannon entropy	6.41
Giraud's	2.24

Perfect single bit faults (simulation)

SECTION 3
IMPROVING ENTROPY-BASED TOOLS

Considering a known fault model

- We want to improve the efficiency of the attack **by including information** of a known model.
- Let $t(e)$ be the expected distribution, we use the relative entropy:

$$RH(p_s, t) = \sum_{e=0}^{255} p_s(e) \log_2 \left(\frac{p_s(e)}{t(e)} \right)$$

	Average best attack
Shannon entropy	6.41
Relative entropy	2.24
Giraud's	2.24

Perfect single bit faults (simulation)

How to learn the fault model $t(e)$

- Use the Shannon entropy in a first attack.
- Inject faults on M10 and observe the resulting fault model.
- We have previous knowledge of the system, the injection means, the countermeasure...

- **Bertoni's countermeasure = 1 parity bit**
- Thus **all odd bit faults are eliminated**. This creates non uniformity!

Modeling basic countermeasures

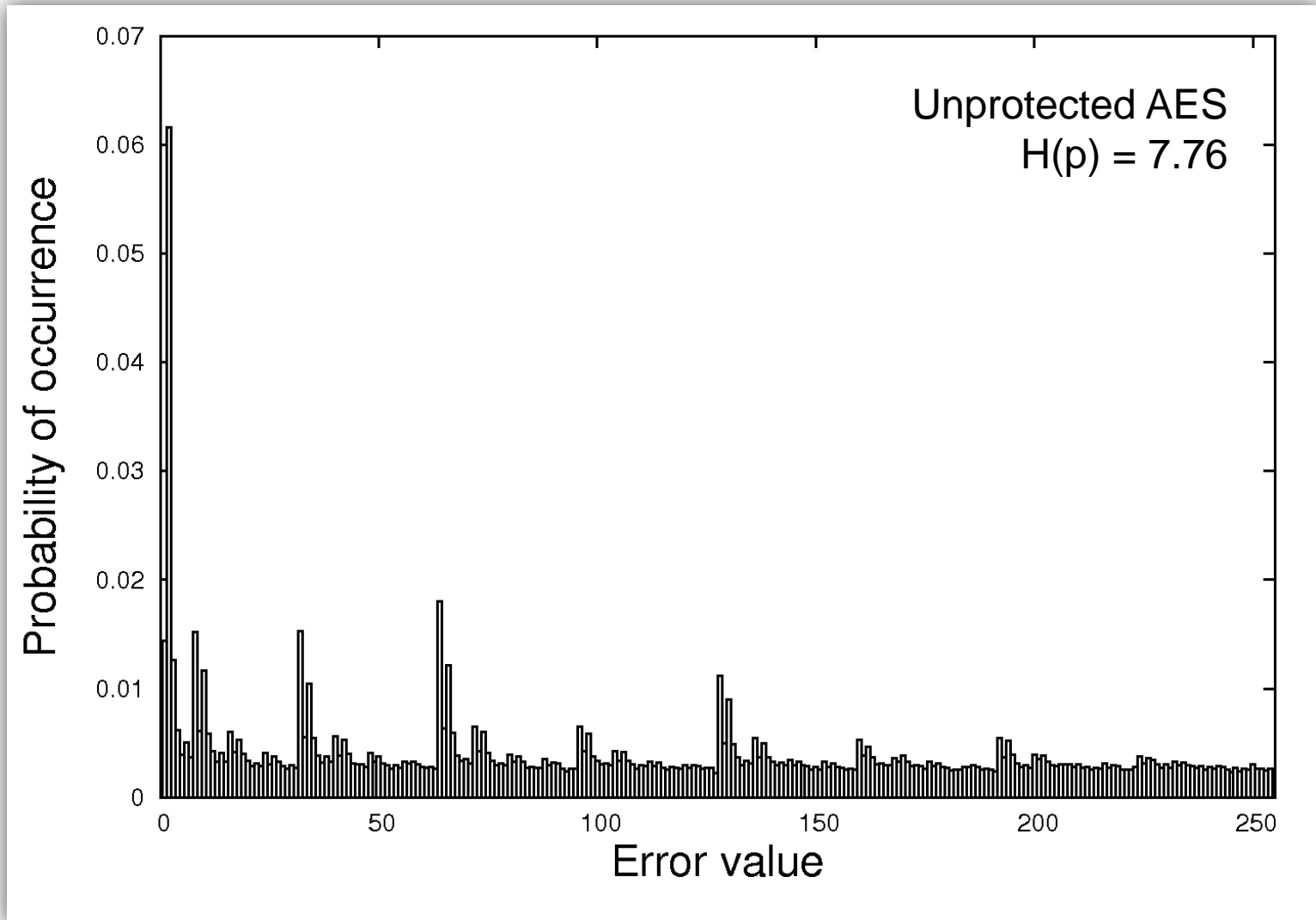
- $d(e)$ is the detection rate for error e .
- $D = \sum_{e=0}^{255} p_{K10}(e) d(e)$ is the global detection rate.
- Two cases:
 - Virtual model with result discrimination: the attacker **knows** for which realizations the countermeasure was activated. The new “virtual” distribution is:

$$v(e) = \frac{p_{K10}(e)(1 - d(e))}{1 - D}$$

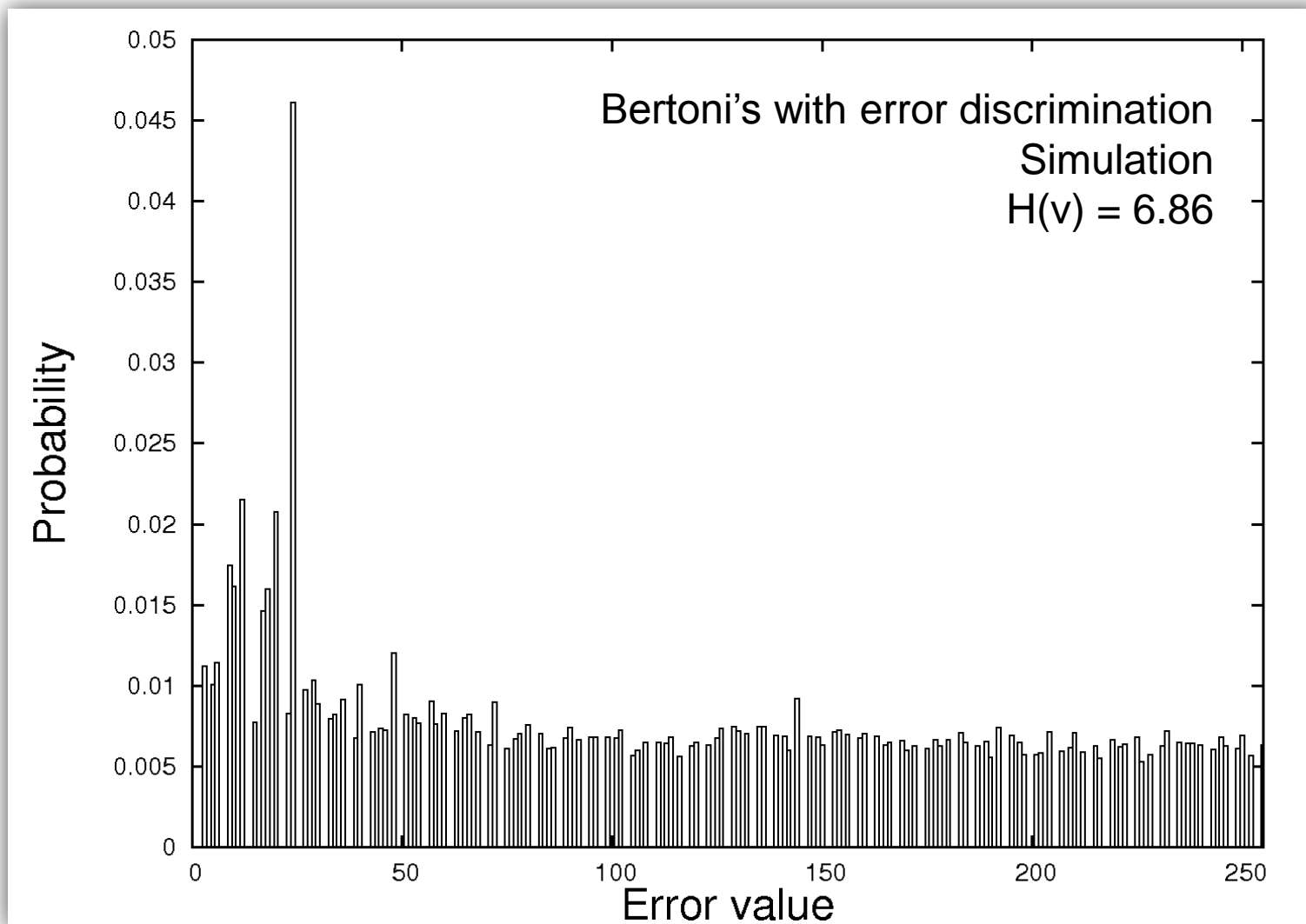
- Virtual model without result discrimination: the attacker **does not know** for which realizations the countermeasure was activated. The new “virtual” distribution is:

$$w(e) = \frac{1}{256} D + p_{K10}(e)(1 - d(e)) = \frac{1}{256} D + (1 - D)v(e)$$

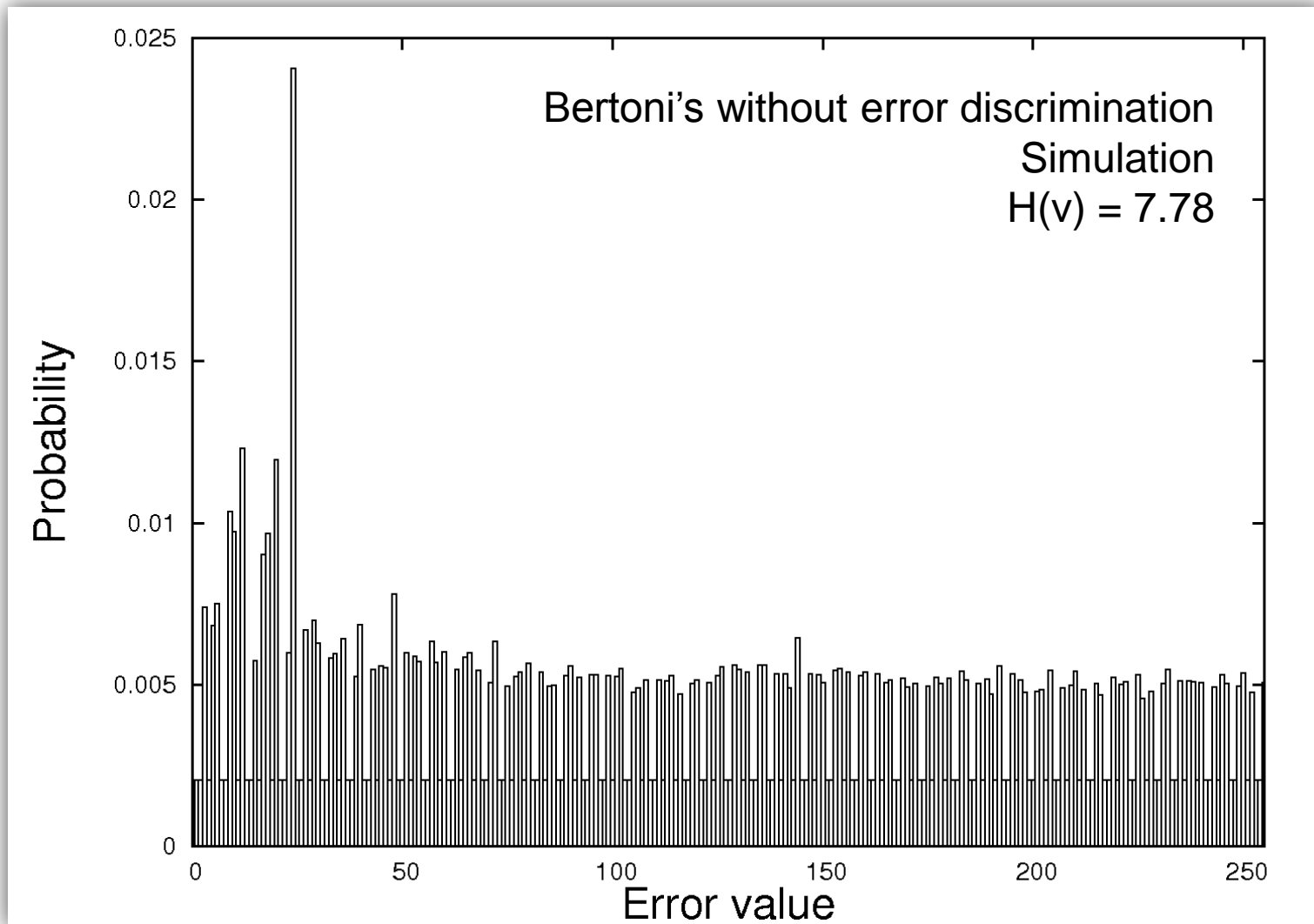
IMPROVING TOOLS: UNPROTECTED AES



IMPROVING TOOLS: BERTONI'S COUNTERMEASURE



IMPROVING TOOLS : BERTONI'S COUNTERMEASURE



Conclusion

- Our DFA is:
 - **General**: can be used with all injection means.
 - **Adaptive**: the efficiency increases when the fault model is tighter.
 - **Simple** to implement.
 - **Without prior knowledge** of the fault model...
 - Or **with prior knowledge** and higher efficiency.
 - Helped by some countermeasures!

- We **loosened the constraints** on the injection means.
- We can find the **key** and the **fault model** in parallel.
- All faults contribute to find the key. The analysis is done by taking into account all faults as a whole.

- Countermeasures must create non uniformity.

Perspectives

- **Verify** that all injection means have non uniform distribution for injected faults.
- **Represent the fault model** with something different than a distribution.
- **Test this methodology** on other algorithms. It should work if we can compute the injected faults with the secret as a parameter.
- **Cartography** for localized injection means should include a fault entropy evaluation.

Thank you for your
attention.

Any questions?



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